

Enhancement Mode N-Channel Power MOSFET

 $TO-252/NMOS/30V/\pm20V/1.6V/120A/2.8m\Omega$

Rev1.1





30V, $2.8m\Omega$, 120A, Single N-Channel

1.Features

- ◆ 30V MOSFET technology
- ◆ Low on-state resistance
- ◆ Fast switching
- ♦ Vgs±20V

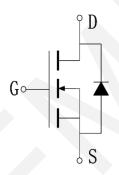
| 2.A | pp | lica | tio | ns |
|-----|----|------|-----|----|
|-----|----|------|-----|----|

- ♦ Power Switching Application
- ◆ Load Switching



TO-252 Pin Description

| V _{DS} | R _{DS(on)} Typ. | I _D Max. |
|-----------------|--------------------------|---------------------|
| 201/ | 2.8mΩ @ 10V | 1004 |
| 30V | 4.0mΩ @ 4.5V | 120A |



Schematic Diagram

3. Package Marking and Ordering Information

| Part no. | Marking | Package PCS/Reel | | PCS/CTN. | |
|----------|----------|------------------|-------|----------|--|
| WP30H20K | WP30H20K | TO-252 | 2,500 | 25,000 | |

4.Absolute Max Ratings at Ta=25°C (Note1)

| Parameter | Symbol | Maximum | Units |
|---------------------------------|-------------------|-------------|-------|
| Drain to Source Voltage | $V_{	extsf{DSS}}$ | 30 | V |
| Gate to Source Voltage | V _{GSS} | ±20 | V |
| Drain Current (DC) | lο | 120 | А |
| Drain Current (Pulse), PW≤300μs | I DP | 480 | А |
| Total Dissipation | P_{D} | 70 | W |
| Avalanche Energy, Single Pulsed | Eas | 121 | mJ |
| Junction Temperature | Tj | 150 | °C |
| Storage Temperature | T_{stg} | -55 to +150 | °C |

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



5. Thermal Resistance Ratings

| Parameter | Symbol | Value | Unit |
|------------------|--------|-------|------|
| Junction to case | Rejc | 1.6 | °C/W |

Note 2: When mounted on 1 inch square copper board $t \le 10$ sec The value in any given application depends on the user's specific board design.

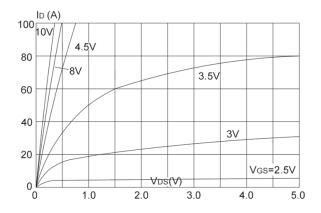
6.Electrical Characteristics at Ta=25°C (Note 3)

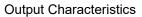
| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Units |
|-----------------------------------|----------------------|---|------|------|------|-------|
| Drain to Source Breakdown Voltage | V _{(BR)DSS} | $I_D = 250 \mu A$, $V_{GS} = 0 V$ | 30 | 34 | | V |
| Zero-Gate Voltage Drain Current | I _{DSS} | V _{DS} =30V, V _{GS} = 0V | | | 1 | μΑ |
| Gate to Source Leakage Current | Igss | $V_{GS} = \pm 20V, V_{DS} = 0V$ | | | ±100 | nA |
| Gate Threshold Voltage | V _{GS(th)} | V _{DS} =V _{GS} , I _{DS} =250µA | 1.0 | 1.6 | 2.5 | ٧ |
| Static Drain to Source On-State | Б | I _D = 30A, V _{GS} = 10V | - | 2.8 | 3.5 | mΩ |
| Resistance | R _{DS(on)} | I _D = 20A, V _{GS} = 4.5V | - | 4.0 | 6.5 | mΩ |
| Input Capacitance | C _{iss} | V _{GS} =0V, | | 2680 | | pF |
| Output Capacitance | Coss | V _{DS} =15V, | | 393 | | pF |
| Reverse Transfer Capacitance | Crss | Frequency=1.0MHz | | 330 | | pF |
| Turn-ON Delay Time | t _{d(on)} | | | 23 | | ns |
| Rise Time | tr | $V_{DS} = 15V, I_{D} = 30A,$ | | 28 | | ns |
| Turn-OFF Delay Time | t _{d(off)} | $V_{GS} = 10V$, $R_{GEN} = 3\Omega$ | | 74 | | ns |
| Fall Time | tf | | | 36 | | ns |
| | Qg | V _{DS} = 15V, | | 30 | | nC |
| Total Gate Charge | Qgs | V _{GS} = 10V, | | 7.2 | | nC |
| | Q _{gd} | I _D = 30A | | 10.4 | | nC |
| Diode Forward Voltage | V _{FSD} | I _S =30A, V _{GS} = 0 | | 0.83 | 1.2 | V |

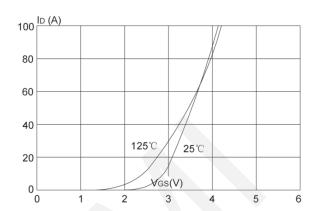
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



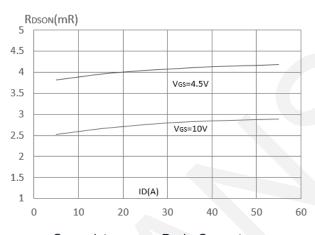
7. Typical electrical and thermal characteristics



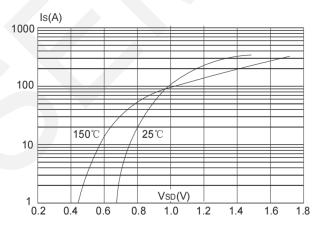




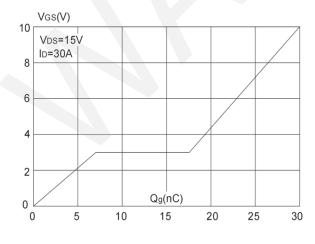
Typical Transfer Characteristics



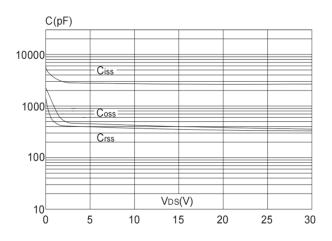
On-resistance vs. Drain Current



Body Diode Characteristics

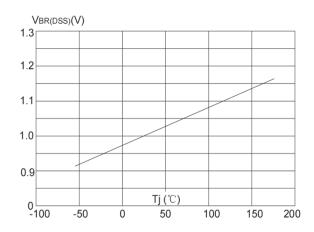


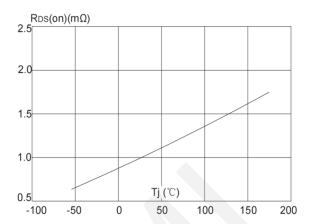
Gate Charge Characteristics



Capacitance Characteristics





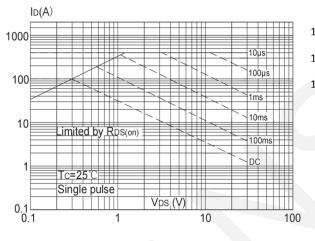


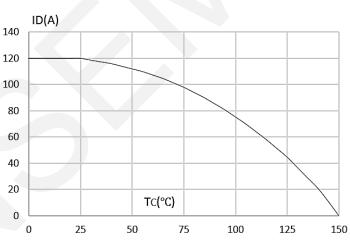
Normalized Breakdown Voltage vs.

Normalized on Resistance vs.

Junction Temperature



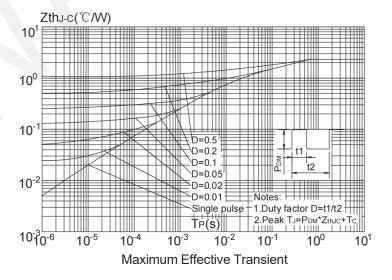




Maximum Safe Operating Area

Maximum Continuous Drain Current vs.

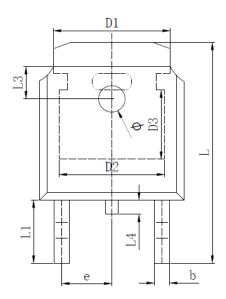
Case Temperature

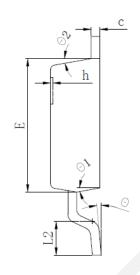


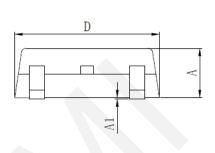
Thermal Impedance, Junction-to-Case



8.Package Dimensions







| SYMBOL | MILLIMETER | | | |
|--------|------------|-----------|---------|--|
| SIMDOL | MIN | Тур. | MAX | |
| A | 2. 200 | 2. 300 | 2. 400 | |
| A1 | 0.000 | | 0. 127 | |
| b | 0. 640 | 0.690 | 0. 740 | |
| c(电镀后) | 0. 460 | 0.520 | 0. 580 | |
| D | 6. 500 | 6. 600 | 6. 700 | |
| D1 | | 5.334 REF | | |
| D2 | | 4.826 REF | | |
| D3 | | 3.166 REF | | |
| E | 6. 000 | 6. 100 | 6. 200 | |
| е | 2.286 TYP | | | |
| h | 0.000 | 0.100 | 0. 200 | |
| L | 9. 900 | 10. 100 | 10. 300 | |
| L1 | 2.888 REF | | | |
| L2 | 1. 400 | 1.550 | 1. 700 | |
| L3 | 1.600 REF | | | |
| L4 | 0.600 | 0.800 | 1. 000 | |
| ф | 1. 100 | 1. 200 | 1. 300 | |
| θ | 0° | | 8° | |
| θ1 | 9° TYP | | | |
| θ2 | 9° TYP | | | |



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